Anodic Electrochromism for Energy-Efficient Windows: Cation/Anion-Based Surface Processes and Effects of Crystal Facets in Nickel Oxide Thin Films

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Anodic electrochromic (EC) oxides are of major interest as counter electrodes for smart window applications owing to their unique optical properties upon charge insertion and extraction. However, performance optimization of such oxides has been hampered by limited understanding of their EC mechanism, particularly in Li⁺-conducting electrolytes. This paper reports on NiOₓ films with 1.16 ≤ x ≤ 1.32, prepared by sputter deposition. These films were immersed in an electrolyte of lithium perchlorate in propylene carbonate, and EC properties were studied by cyclic voltammetry and in situ optical transmittance measurements. The electrochromism was significantly enhanced at large values of x. We find that charge exchange in Ni oxide is mainly due to surface processes and involves both cations and anions from the electrolyte, which is different from the case of cathodic EC materials such as WO₃. Whereas previous studies of Ni oxide have focused on cation intercalation, the cation/anion-based mechanism presented here offers a new paradigm for designing and developing EC devices such as smart windows for energy efficient buildings.
1. Introduction

Electrochromic (EC) oxides exhibit reversible changes of their optical properties under the application of a voltage and resemble electrical batteries in that they involve joint transport of electrons and ions\(^{1, 2}\). A typical device has a centrally positioned electrolyte—usually a thin inorganic film or a polymer layer—straddling two EC oxide films, and this three-layer structure is surrounded by transparent electrodes. The optical modulation is highest if one of the EC oxides colors under ion insertion (cathodically) while the other EC oxide colors under ion extraction (anodically). Specifically, the cathodic component is normally based on W oxide while the anodic part is based on Ni oxide\(^{1, 3-5}\), the ions should be small in order to allow facile transport, and protons (H\(^+\)) or Li\(^+\) are most commonly used. EC devices of this type have many applications in contemporary and forthcoming technology; the largest one, at least in terms of surface area, is in glazings for energy efficient buildings\(^{4, 6, 7}\). In this case, optical transmittance modulation can be used to diminish the need for energy guzzling air conditioning and simultaneously provide a comfortable indoor environment\(^ {8-11}\).

The mechanism for coloring and bleaching under charge insertion/extraction in EC oxides has been subject to numerous investigations and speculations for many years. This mechanism is rather well understood for W oxide and involves polaron absorption across a wide wavelength range centered in the near-infrared and extending over most of the luminous spectrum\(^ {3}\). For Ni oxide, on the other hand, the cause of the electrochromism is much more unsettled despite the fact that scientific inquiry has persisted for almost thirty years\(^ {12}\), and not only is the absorption mechanism poorly understood but even the ionic species involved in the optical modulation are sometimes ambiguous. These uncertainties are notable particularly in the case of Li\(^+\)-based electrolytes, whereas extensive work\(^ {13, 14}\) on Ni oxide in KOH has shown that electrochromism is associated with reversible charge-transfer processes between
Ni$^{2+}$ and Ni$^{3+}$ and can be reconciled with proton exchange in accordance with an extension of the well-established Bode reaction scheme$^{[15,16]}$.

This paper reports on a detailed study of Ni oxide films in an electrolyte of lithium perchlorate in propylene carbonate (LiClO$_4$–PC). We find strong indications that the electrochromism is largely governed by surface processes, and that both cations and anions are involved in the charge exchange. The paper is organized as follows: Section 2 reviews the state-of-the art for understanding Li$^+$ exchange in Ni oxide. The composition and structure of our Ni oxide films are then described in Section 3, and electrochemical and optical properties are reported in Section 4. Section 5 contains a critical discussion of these data and their interpretation, and conclusions are drawn in Section 6. Section 7 describes the preparation and characterization of our Ni oxide films.

2. Li$^+$ Exchange in Ni Oxide: A Critical Assessment

The electrochromism of lithium-containing Ni oxide films has been investigated in numerous studies aimed at elucidating basic optical and electrochemical mechanisms$^{[17-33]}$ as well as to produce counter electrodes for application in W-oxide-based EC devices$^{[5,27,32,34-38]}$.

We first consider work by Passerini et al.$^{[17-19,22,39]}$, who proposed a simple two-step electrochemical reaction scheme for Li$^+$ insertion/extraction in sputter-deposited Ni oxide films immersed in LiClO$_4$–PC. This scheme involves an initial irreversible bleaching of the as-deposited Ni oxide by

\[
\text{NiO}_x + y\text{Li}^+ + ye^- \rightarrow \text{Li}_y\text{NiO}_x ,
\]  

(1)

where $e^-$ denotes electrons, followed by a reversible reaction between bleached Li$_y$NiO$_x$ and colored Li$_{(y-z)}$NiO$_x$ as described by

\[
\text{Li}_y\text{NiO}_x \leftrightarrow \text{Li}_{(y-z)}\text{NiO}_x + z\text{Li}^+ + ze^- .
\]  

(2)
Hence this scheme presumes that “activated” \( \text{Li}_x\text{NiO}_x \) is the electrochemically active material. It should be noted that the electrochemical studies of Passerini et al. employed very low potentials, down to 1.1 V vs. Li, and the initial irreversible “activation” was due to an imbalance between insertion/extraction of charge at potentials below 1.5 V vs. Li. This potential range allows a number of reactions between Li, oxide materials and electrolytes, and Li-based oxides and hydroxides can form in particular as surface layers\[^{[40]}\]. For example, Poizot et al. \[^{[41, 42]}\] suggested that reversible formation of metal nanoparticles can occur in a matrix of \( \text{Li}_2\text{O} \) when the potential is below 2 V vs. Li in accordance with

\[
\text{NiO} + 2\text{Li}^+ + 2e^- \leftrightarrow \text{Ni} + \text{Li}_2\text{O} .
\]  

However, such a reaction would lead to coloration of the sample due to optical absorption in Ni particles\[^{[43, 44]}\] and therefore obliterate the electrochromism. Thus the use of working potentials below 2 V vs. Li seems to be plagued with irreversible side reactions and, furthermore, is not compatible with the electrochemically reversible region of W oxide in an EC device\[^{[3]}\]; it therefore remains questionable whether reactions (1) and (2) have any bearing on the electrochromism in a functioning device.

Campet et al.\[^{[20]}\] put forward an alternative model for the electrochromism in Ni oxide, built on the notion that hydrogen in \( \text{NiOOH} \) migrates from the surface (surf) to the bulk according to

\[
2\text{NiOOH}\text{[surf]} + (1 - 2x)\text{NiO}\text{[bulk]} + 2x\text{Li}^+ + 2xe^- \rightarrow \text{Li}_{2x}\text{Ni}_{(1 - x)}\text{O}_{[surf]} + x\text{Ni(OH)}_2\text{[bulk]} ,
\]  

where \( \text{NiOOH} \) is colored and the other oxide phases are transparent. The Li-containing surface layer is then optically modulated by \( \text{Li}^+ \) insertion/extraction, and the absorption strength is governed by the \( \text{Ni}^{3+} \) concentration by

\[
\text{Li}^+_{2x}\text{Ni}^{2+}_{(1 - x)}\text{O}^{2-} \leftrightarrow \text{Li}^+_{(2x - y)}\text{Ni}^{2+}_{(1 - x - y)}\text{Ni}^{3+}_y\text{O}^{2-} + y\text{Li}^+ + ye^- ,
\]  

where \( \text{Li}^+_{2x}\text{Ni}^{2+}_{(1 - x)}\text{O}^{2-} \) is transparent and \( \text{Li}^+_{(2x - y)}\text{Ni}^{2+}_{(1 - x - y)}\text{Ni}^{3+}_y\text{O}^{2-} \) is colored.
The importance of surfaces for the EC activity of Ni oxide films has been highlighted several times in connection with non-aqueous electrolytes, and it has been shown that NiO surfaces are covered by adsorbed protons and OH\(^-\) groups in the presence of very small amounts of water\[^{45}\]. Specifically, hydroxide groups can be adsorbed at nickel surface sites and hydrogen at oxygen sites. As discussed by Boschloo and Hagfeldt\[^{24}\], such surface ions can be replaced by ions from the electrolyte, and it was found that the electrochemical response of sol–gel-deposited Ni oxide films was affected primarily by the type of cation in the electrolyte. Boschloo and Hagfeldt\[^{24}\] interpreted their observed electrochromism as an effect of cation desorption/adsorption; cation desorption led to coloration due to electron extraction from the back contact and ensuing increased proportion of Ni\(^{3+}\) species in the film, while cation re-adsorption yielded bleaching.

However, qualitatively different results were observed in recent work by Mihelčič \textit{et al.} \[^{29}\] who investigated Ni oxide pigment coatings, prepared by spin coating, in an electrolyte of tetrabutylammonium triflate and detected adsorbed triflate ions in the colored state by \textit{ex situ} infrared (IR) absorption, thus indicating that the observed electrochromism would be associated with adsorption of anions on the surfaces. In contrast, no perchlorate ions were detected in the bleached or colored states when cycling in LiClO\(_4\)–PC. These observations may be taken to indicate that the mechanism for optical coloration and bleaching depends on the type of electrolyte; the conclusion is provisional, however, since a rinsing procedure was performed before recording the \textit{ex situ} IR spectra, which may have affected adsorbed surface species in different ways. Furthermore, Mihelčič \textit{et al.} \[^{29, 46, 47}\] observed distinct differences in IR absorption bands due to OH\(^-\) between the bleached and colored states, which may indicate that protons and/or hydroxide ions participate in the EC process. Specifically, a distinct OH\(^-\) band was observed only in the bleached state, while a broader band was seen in the colored state\[^{29}\]. The intensity of the signal due to OH\(^-\), for the bleached state, became smaller upon
voltage cycling, which suggests that OH\textsuperscript{-} species are involved in the EC process mainly for the initial cycles.

It is evident from the discussion above that the electrochromism of Ni oxide films in Li\textsuperscript{+}-conducting electrolytes is a contentious subject. In order to progress towards a deeper understanding, the Ni oxide films therefore must be prepared under carefully controlled conditions and, furthermore, a well-chosen set of experiments is necessary. Specifically, our present work employs thin film fabrication by reactive DC magnetron sputtering, which minimizes contamination, and exercises detailed control of crystallinity, stoichiometry and surface texture through a judicious selection of sputter parameters such as gas pressure, discharge power and substrate temperature\textsuperscript{[48, 49]}. The films were then studied by cyclic voltammetry (CV) and \textit{in situ} optical transmittance measurements, as discussed below.

3. Composition and Structure of Ni Oxide Thin Films

Nickel and oxygen contents for NiO\textsubscript{x} films were determined by Rutherford Backscattering Spectrometry (RBS), which yielded values of \( x \) in the range \( 1.16 \leq x \leq 1.32 \) as shown in Figure 1a. Hydrogen cannot be detected by RBS but probably exists in the films and/or at their surfaces. Film density \( \rho \) was calculated from RBS data and was found to be 5.0, 4.9 and 5.3 g/cm\textsuperscript{3} for \( x \) being 1.16, 1.25 and 1.32, respectively. Bulk NiO has a density of 6.67 g/cm\textsuperscript{3}.

Figure 1b displays X-ray diffraction (XRD) patterns for NiO\textsubscript{x} films with \( x \) being 1.16, 1.25 and 1.32 as well as for an uncoated ITO/glass substrate. The films show clear evidence for NiO with cubic \textit{fcc} structure (JCDPS No. 47–1049); peaks emanating from the (111), (200), (220), (311) and (222) reflections are apparent, and no evidence is found for Ni\textsubscript{2}O\textsubscript{3} or any other Ni oxide. We reiterate that a very thin layer of hydroxide may be present on the surfaces of the NiO grains but remains undetected by XRD. Crystallite sizes were estimated
from Scherrer’s formula\[50\] applied to the diffraction peak at \(~37^\circ\) and were found to be \(~12.2, 11.1\) and \(10.8\ nm\) for NiO\(_{1.16}\), NiO\(_{1.25}\) and NiO\(_{1.32}\), respectively.

The relative peak heights in the diffractograms differ strongly among Ni oxide films with various values of \(x\) and signal different types of preferred orientation of the lattice planes. Thus the NiO\(_{1.16}\) film has a strong peak designated \((111)\) and an even stronger peak for the \((200)\) growth direction, whereas the NiO\(_{1.25}\) film has reversed intensities for these peaks; these results indicate a strong transformation from \((200)\) to \((111)\) growth direction as \(x\) is increased from 1.16 to 1.25. Furthermore, the feature due to the \((200)\) planes has almost vanished in the NiO\(_{1.32}\) film and the \((111)\) peak then dominates strongly, implying that most of the grains grow with \((111)\) orientation. Our data agree with prior work which has stated several times that the \((111)\) growth direction tends to be favored when Ni oxide films are produced in the presence of a sufficient amount of oxygen\[51-53\].

**Figure 2** reports scanning electron microscopy (SEM) data for NiO\(_{x}\) films with \(x\) being 1.16, 1.25 and 1.32 and shows that the surface features are dependent on the stoichiometry and vary from triangular-shaped at \(x = 1.16\) to more rod-like at \(x = 1.32\). The triangular shapes are consistent with the morphology of our NiO\(_{1.22}\) films reported on before\[30\]. The features observed in the SEM images clearly are larger than the grain sizes indicated by XRD and must consist of several grains.

**4. Electrochemical and Optical Properties**

**4.1 Cyclic Voltammetry and Spectral Optical Transmittance**

**Figures 3a–c** display the first five CV scans at 2.0–4.1 V vs. Li for NiO\(_{x}\) films with \(x\) being 1.16, 1.25 and 1.32, respectively. The cycling began at the open circuit potential (OCP) and progressed towards lower potentials. The subsequent full cycles showed qualitatively similar CV data for each of the films and indicated good electrochemical durability.
voltammograms were dependent on the value of $x$ and, generally speaking, the charge exchange was enlarged as $x$ was increased. A difference between the first CV cycle and the subsequent ones is noted for increasing potential from 2.0 to 4.1 V vs. Li, especially for $x$ being 1.16 and 1.25, which may be due to desorption of H$^+$ from oxygen sites on NiO$_x$ as discussed in detailed later. Figures 3a’–c’ report spectral optical transmittance for the same films in initial, as-deposited state and after coloring and bleaching corresponding to zero current density in the CV scans. The transmittance of the as-deposited films were lower the larger the oxygen content, which can be reconciled with a higher proportion of Ni$^{3+}$ sites and a larger amount of Ni vacancies. During the first voltammetric half-cycle from the OCP and towards 2.0 V vs. Li, the optical transmittance changes from the initial condition to a bleached state with significantly higher transmittance, and coloration then takes place as the potential is swept towards 4.1 V vs. Li. It is important to note that the transmittance in the stabilized, colored (bleached) state is lower (higher) than that of the as-deposited sample. The colored-state transmittance is also progressively lower in films with increased values of $x$. Films with small oxygen content showed high as-deposited and bleached-state transmittance and the coloration was rather modest; films with higher oxygen content, on the other hand, showed lower bleached-state transmittance but larger optical modulation.

In the previous data, the cyclic voltammograms were recorded as the voltage was initially swept from the OCP towards the lower potential limit at 2.0 V vs. Li with ensuing bleaching of the sample. Alternatively, the initial half cycle can progress from the OCP towards the upper potential limit at 4.1 V vs. Li. Figure 4 shows a comparison of data obtained in the different manners for a Ni oxide film with $x = 1.16$. The film displays almost the same charge insertion and extraction properties after the first CV cycle and identical stable coloration and bleaching in both cases. Importantly, the optical transmittance increases during the initial scan from OCP to 2 V vs. Li (Figure 4c, inset) and decreases during the initial CV scan from
the OCP to 4.1 V vs. Li (Figure 4d, inset). Clearly the Ni oxide can be bleached or colored from the as-deposited state depending on voltage scan direction.

**Figure 5** elaborates the role of the upper potential window, denoted $U_H$, for the electrochemical and optical properties of NiO$_x$ films. Figures (a)–(c) refer to the second, electrochemically stabilized, CV cycle for films with $x$ being 1.16, 1.25 and 1.32, respectively. $U_H$ was set at four values from 3.7 to 4.7 V vs. Li and, expectedly, the charge exchange is markedly increased in proportion to the magnitude of $U_H$. Charge exchange takes place in a wider potential range when the oxygen content is increased in NiO$_x$. Figures 5a’–c’ show that all of the films have a transmittance around 90% at a mid-luminous (550 nm) wavelength irrespectively of the width of the potential window. For $x = 1.16$, the film colored by sweeping the potential to $U_H = 3.7$ V vs. Li has almost the same optical properties as in the as-deposited state, whereas films characterized by $x$ being 1.25 and 1.32 were then somewhat more transparent than in their corresponding as-deposited states. The optical modulation span becomes larger as $U_H$ is enlarged and also—to an even larger extent—as $x$ is increased; in other words, large oxygen content is conducive to electrochromism.

Charge insertion/extraction as a function of cycle number is illustrated in detail in **Figure 6** for three types of Ni oxide films and in four potential windows. The charge exchange during the first bleaching is in most cases considerably less than in subsequent cycles, as also inferred from the CV data in Figures 3–5. Extended CV cycling leads to a slow and monotonic decrease of the charge densities for coloring and bleaching; the fall-off takes place at a rate that levels off as the cycle number progresses. This behavior is in qualitative agreement with a power-law decay reported for Ni oxide films cycled for up to $10^4$ times in earlier work of ours$^{[30]}$. With one clear exception (Figure 6i), the charge for coloration is somewhat larger than that for bleaching after the first CV cycle. The charge exchange is enhanced for increased values of $x$ and $U_H$. 9
4.2 Fractal Dimension of the Films’ Surface Structure

The Ni oxide films have very uneven surfaces, as apparent from the SEM data in Figure 2, and it is important for our analysis below that this roughness is quantified, which can be done by use of a fractal dimension $d_f$ for the surface. We extracted $d_f$ by taking CV data at different voltage sweep rates by use of the Randles–Sevčík (R-S) equation\cite{54,55} or its fractal generalization\cite{56-58}.

Figure 7a reports CV scans obtained by using sweep rates from 2 to 100 mV/s for a film with $x = 1.16$. These data consistently show one pronounced peak in (negative) current density ($I$) during the sweep towards lower potentials. The peak current was found to depend as a power law on sweep rate, as seen in Figure 7b, which also shows data for films with $x = 1.25$ and $x = 1.32$. The fractal generalization of the R-S equation gives that the power-law exponent $\alpha$ is related to the fractal dimension as

$$\alpha = (d_f - 1)/2,$$  \hspace{1cm} (6)

which yields $d_f$ values in the narrow range $2.80 \pm 0.06$.

5. Discussion

5.1 Electrochemical Reactions are Surface Processes

We first consider the oxygen excess in the as-deposited Ni oxide films, which were produced by sputtering in pure oxygen–argon plasma. $H^+$ and $OH^-$ can adsorb on the NiO surface when the film is exposed to ambient atmosphere\cite{45}. Hence it is plausible that some hydroxide and oxyhydroxide species are present on the surfaces, and it is often assumed\cite{13,14} that Ni oxide films with EC properties consist of NiO grains with outer layers of Ni(OH)$_2$ and NiOOH. In transparent films, the oxygen excess must be due exclusively to Ni(OH)$_2$ whereas absorbing
fils must contain NiOOH and/or Ni$_2$O$_3$; the latter species is likely to be hydroxylated upon exposure to ambient air, at least if present on a surface.

Both Ni(OH)$_2$ and NiOOH can be represented as NiO$_{(1+\gamma)}$ with $\gamma = 1$, and Ni$_2$O$_3$ has $\gamma = 0.5$, whereas our films are characterized by $0.16 \leq \gamma \leq 0.32$, and it is interesting to contemplate where the (oxy)hydroxide (or dinickel trioxide) is located in our samples. To this end we first estimate the surface/volume ratio $(S/V)_g$ of NiO grains assuming that they are spherical with radius $R$ and have a surface layer thickness $\Delta R$, so that $(S/V)_g = 3\Delta R/R$. Setting $\Delta R = 0.42$ nm, corresponding to one lattice constant in NiO, and $2R = 12$ nm to be consistent with the grain size inferred from XRD data in Figure 1b, we obtain $(S/V)_g = 0.21$. This is of the same order of magnitude as the oxygen excess in our samples and indicates that the species contributing to the oxygen excess are present as thin layers at grain boundaries.

How much of the oxygen excess in our films is due to Ni(OH)$_2$ and how much to the absorbing species? The films were almost completely bleached during the initial voltammetric half-cycle towards low potentials (cf. Figure 4), and the charge exchange per area unit ($Q/A$) during this half-cycle allows an estimate the number $q$ of exchanged monovalent ions per Ni atom from

$$q = (M_{\text{mol}}/ed\rho N_A) \cdot (Q/A) , \quad (7)$$

where $M_{\text{mol}}$ is molar mass of NiO, $d$ is film thickness and $N_A$ is Avogadro’s constant. From Figure 6, the charge density after the first bleaching corresponds to a charge exchange of 0.5–0.7 mC/cm$^2$ for films with $\gamma = 0.16$ and $\gamma = 0.25$, and of ~2.5 mC/cm$^2$ for $\gamma = 0.32$. Using $\rho \approx 5.0$ g/cm$^3$, one finds corresponding $q$ values of ~0.003 and ~0.011.

At face value, the smallness of this parameter indicates that the majority of the oxygen excess in our films would be due to Ni(OH)$_2$, and it is highly probable that absorbing species exist only on the film surface, i.e., where reactions with the ions of the electrolyte are most
facile. However, the analysis can be refined, and we therefore introduce a ratio \((S/V)_f\) ratio for the film, whose minimum value is \(\sim \Delta R/d\), i.e., \(\sim 0.0014\) in the present case. We recall that the film surfaces are rough (cf. Figure 2), and an “amplification factor” for \((S/V)_f\) can be estimated from the fractal dimension estimated from the data in Figure 7. We assume that the inner cut-off for the fractal structure is equal to the lattice constant and that the outer cut-off (correlation length \(\xi\)) is equal to the radial size of the features seen in Figure 2, i.e., approximately 20 nm. The area of a flat surface scales as \(r^2\) and the area of a fractal surface scales as \(\xi^{df}\), where \(r\) is a distance on the surface. Hence the “amplification factor” is \(\sim (\xi/\Delta R)^{df-2}\), where \(r\) was replaced by the ratio between the correlation length and the lattice constant. Our estimated \((S/V)_f\) ratio then becomes \(\sim 0.03\), which is much higher than \(q\), but it must be borne in mind that this is an order-of-magnitude estimate only. Nevertheless, our estimate is clearly consistent with the assumption that the absorbing species are confined to the surface of the Ni oxide films. Furthermore, it is interesting to note that the maximum coloration charge, observed in Figure 6 for the upper potential limit 4.7 V vs. Li, translates to \(q \sim 0.024\), which is in very good agreement with our estimate. Our results hence indicate that the whole surface area is fully occupied by absorbing species only at high applied potentials.

### 5.2 Crystal Facets are Important for Strong Electrochromic Coloration

We now consider the relation between, on one hand, the degree of optical absorption and the possible species adsorbed on the surface and, on the other hand, the different preferential orientations of the films as evidenced in Figure 1b where we emphasized the roles of the (111) and the (200) crystal facets. As illustrated in Figure 8, the (111) planes in NiO are terminated by Ni atoms, while the (200) planes are terminated by both oxygen and nickel atoms\(^{[45,59]}\). Importantly, these two types of planes have different abilities to adsorb cations and anions; when NiO films are exposed to the atmosphere, OH\(^-\) ions are adsorbed on the Ni sites and H\(^+\) ions on the O sites of the surface. According to Boschloo and Hagfeldt\(^{[24]}\) the
metal sites attain the charge state Ni\(^{2+}\) in the case of equal amounts of the two adsorbed species. It should be noted that the (111) planes have the highest density of atomic sites and that, under ambient conditions, it is easier to adsorb OH\(^-\) on the exposed Ni sites than protons to the underlying O sites, the net result leading to the formation of NiOOH and yielding low optical transmittance in the initial state. Cappus\(^{[45]}\) also experimentally found a higher proportion of OH\(^-\) adsorption on the (111) surface than on the (200) surface of NiO.

How can the observations above account for the differences in optical absorption for the various as-deposited NiO\(_x\) films? Optical absorption would be due to an excess of adsorbed OH\(^-\), compared to the amount of adsorbed H\(^+\)\(^{[24]}\), and lead to the formation of Ni\(^{3+}\) sites, which would be most likely on the (111) planes since their O atoms lie below the Ni atoms and hence are less accessible. The comparatively strong optical modulation for NiO\(_{1.32}\) would then be due to the abovementioned effect and ensue from an additional contribution due to the small interatomic distances in the (111) plane. All of the Ni oxide films were almost completely bleached during the initial half-cycle, most probably as a consequence of desorption of OH\(^-\) from easily accessible Ni sites on the surface. Instead going from the as-deposited state to the colored state in the initial voltammetric half-cycle, protons can be desorbed and give increased optical absorption. However adsorption of anions from the electrolyte onto less accessible Ni sites may also contribute, at least at high potentials.

The most oxygen-rich film, NiO\(_{1.32}\), shows the largest charge exchange and yields the largest optical modulation, which is consistent with the arguments above. This film also displays the largest optical variation from initial state to bleached state. These features are probably due to the film’s large proportion of Ni sites on the exposed (111) planes. Correspondingly, oxygen atoms are less exposed; this implies that few protons are present initially and amenable to desorption, which results in a small optical difference between the
initial state and colored state at potentials below 4.1 V vs. Li. The increased optical absorption at higher voltages should, at least partly, be due to adsorption of anions from the electrolyte.

The case is different for films of NiO$_{1.25}$ and NiO$_{1.16}$, however, since they have strong XRD reflections due to both (111) and (200) planes, which indicates a smaller difference in the number of exposed oxygen and nickel atoms. The optical absorption in the as-deposited films is lower than for NiO$_{1.32}$, as apparent from Figure 5, and is due to the difference of adsorbed OH$^-$ and protons on easily accessible surface sites. The variation of optical absorption from the initial state to both bleached and colored states is similar at the upper potential, 4.1 V vs. Li. The decreased colored-state transmittance at higher potentials is believed to be due to a combination of proton desorption and of adsorption of anions from the electrolyte. Thus we conclude that the degree of optical absorption in the as-deposited films, as well as the achievable contrast between bleached or colored states, is determined by exposed crystallographic planes. The initial bleaching of the films reported on in Figure 4a can then be understood as a result of OH$^-$ ion desorption from the surface, while the initial coloring of the film reported on in Figure 4b is at least partly due to H$^+$ ion desorption.

Considering next the coloration–bleaching mechanism in subsequent cycles, it is unlikely that the coloration of the Ni oxide films following the first bleaching is caused solely by the adsorption of anions, irrespectively of them being OH$^-$ or ClO$_4^-$ . Since the charge exchange during the first coloration is larger than during the initial bleaching, desorption of cations should also contribute. The same argument can be applied to the bleaching after the first coloration in Figure 4b. We also note that the charge density during the first coloration (1.91 mC/cm$^2$) in Figure 4a is slightly larger than the sum of the initial half-cycles in Figures 4a and 4b (0.59 + 1.27 = 1.86 mC/cm$^2$), which may suggest that the first coloration is due not only to adsorption of OH$^-$ and desorption of protons but that ions of the electrolyte contribute.
Hence we propose that the coloration/bleaching processes after the first half-cycle are due to a combination of cation and anion exchange. Desorption of cations and adsorption of anions leads to extraction of electrons from the back contact (the ITO layer) whereby the film colors, and the opposite processes occur during bleaching. In addition, after the first cycle the importance of proton and hydroxide exchange gradually decreases and it is mainly the ions in the electrolyte that will take part in the adsorption/desorption processes at the surface. This interpretation is consistent with the observation of \textit{ex situ} spectro-electrochemical results of Orel \textit{et al.} which showed that OH\textsuperscript{−} signatures became progressively less prominent upon CV cycling during the first few cycles for NiO\textsubscript{x} films\textsuperscript{[29,60]}. The adsorption of Li\textsuperscript{+} and ClO\textsubscript{4}\textsuperscript{−} will, in the absence of side reactions, eventually prevail.

By analyzing correlations between the colored state and the upper potential limit, we found that the charge exchange is markedly enhanced as \(U_H\) is increased from 3.7 to 4.7 V \textit{vs}. Li (Figures 5a–c), thereby yielding a lowered transmittance in the colored state (Figures 5a’–c’). This result indicates that there are surface sites with a broad distribution of adsorption and desorption energies, and that less accessible sites need a higher potential to take part in the processes.

We finally note that Figure 6 reports that, with some exception, the charge for coloration is somewhat larger than that for bleaching. This difference points at a small irreversibility in the adsorption and/or desorption process, and it seems that all inserted anions cannot be extracted. This small irreversibility leads to a minor gradual decrease in the charge capacity. However Figure 6i, pertaining to the most oxygen-rich film and the smallest potential window (2.0–3.7 V \textit{vs}. Li), is qualitatively different; this figure shows that the charge exchange for bleaching is larger than for coloring in the first cycles, and one can observe that the bleached state has higher transmittance than in the initial state, thus indicating that the initial desorption of anions has not all been compensated by adsorption at 3.7 V \textit{vs}. Li. However, after a few
cycles the coloration and bleaching charge densities exhibit the same behavior as for the other cases in Figure 6.

6. Conclusion

We presented results from a comprehensive study of well-characterized sputter-deposited Ni oxide films immersed in a LiClO$_4$–PC electrolyte. Cyclic voltammetry and in situ spectral optical transmittance were recorded for NiO$_x$ films with $1.16 \leq x \leq 1.32$, and it was found that the optical modulation range was enhanced as $x$ was increased and as the potential window for voltammetric cycling was enlarged. These films had different preferred orientations, which were found to be related to the achievable degree of coloration and hence very significant for the electrochromic properties. Furthermore, our data are consistent with a model assuming that both cations and anions contribute to the charge exchange—and hence the electrochromism—and that these ions partake in surface reactions rather than processes in the bulk.

Our work has led to a refined conceptual framework for discussing the electrochromism of Ni oxide in contact with Li$^+$-conducting electrolytes, which thus far has been an elusive topic and subject to speculations for many years. Our new model may also turn out to be useful for understanding ageing and degradation of EC devices incorporating Ni oxide, which is an important topic for smart windows in energy efficient buildings.

7. Experimental Section

Thin film deposition: The Ni oxide films were deposited by reactive DC magnetron sputtering in a coating system based on a Balzers UTT 400 unit as described in detail elsewhere$^{[30]}$. The sputtering chamber contained 30 mTorr of argon and oxygen gas, and films of NiO$_x$ with 1.16
$\leq x \leq 1.32$ were prepared by varying the O$_2$/Ar ratio from 2.0 to 10%. These films were deposited onto unheated substrates of ITO-coated glass for EC measurements and simultaneously onto carbon plates for compositional determinations. The ITO (i.e., In$_2$O$_3$:Sn) layer had a sheet resistance of 60 $\Omega$. Substrate rotation during sputter deposition ensured film uniformity. The film thickness was determined to be 280–300 nm by surface profilometry using a Dektak XT instrument. Films deposited with successively larger O$_2$ contents in the sputter plasma had a progressively more brownish appearance.

**Compositional characterization:** Nickel and oxygen contents were determined by Rutherford Backscattering Spectrometry at the Uppsala Tandem Laboratory, using 2 MeV $^4$He ions back scattered at an angle of 170 degrees. The RBS spectra were fitted to a model for the film–substrate system by use of the SIMNRA program[61].

**Structural and morphological characterization:** Film crystallinity was investigated by x-ray diffraction using a Siemens D5000 diffractometer with CuK$_\alpha$ radiation at a wavelength of 0.154 nm. Structure and phase composition were obtained by comparison with the Joint Commission of Powder Diffraction Standards (JCPDS) database. Film morphology was characterized by scanning electron microscopy using a LEO 1550 FED Gemini instrument with an acceleration voltage of 10–15 kV.

**Electrochemical and optical properties measurements:** Cyclic voltammetry was carried out in a conventional three-electrode cell by use of a computer-controlled ECO Autolab/GPES Interface. A Ni oxide film served as working electrode and was immersed in an electrolyte of 1 M LiClO$_4$ in PC. Both counter electrode and reference electrode were Li foils. The voltage was normally swept at 50 mV/s in the range between a low potential of 2.0 V vs. Li and a high voltage set in the range 3.7–4.7 V vs. Li; the arrangements and settings are consistent with those in earlier work of ours[30, 31, 62].

Charge capacity was determined from CV data is by
\[ C = \int \frac{j\,dV}{s} \]  

(9)

where \( C \) is charge capacity (mC/cm\(^2\)), \( j \) is current density (mA/cm\(^2\)), \( s \) is scan rate (V/s) and \( V \) is voltage (in V).

Spectral optical transmittance was recorded \textit{in situ} in the 380–800 nm wavelength range (corresponding to luminous radiation) during electrochemical cycling; data were obtained by using a fiber-optical instrument from Ocean Optics. The electrochemical cell was positioned between a tungsten halogen lamp and the detector, and the 100-\%-level was taken as the transmittance before insertion of the sample in the electrolyte.

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Figure 1. a) Experimental and simulated RBS spectra for Ni oxide films with the shown O/Ni atom ratios. Recorded RBS spectra were fitted to a model of the film–substrate system by use of the SIMNRA program. b) X-ray diffractograms, showing intensity in arbitrary units (a.u.) vs. twice the diffraction angle, for Ni oxide films with the stated compositions and for a bare ITO/glass substrate. Dashed vertical lines show the positions of five diffraction peaks associated with NiO. Diffraction peaks indicated by diamonds at the uppermost diffractogram are due to ITO. The curves are vertically displaced.
Figure 2. SEM images for films of a) NiO$_{1.16}$, b) NiO$_{1.25}$ and c) NiO$_{1.32}$. Scale bars are 200 nm in length.
Figure 3. Cyclic voltammograms and spectral transmittance for Ni oxide films with the shown compositions immersed in LiClO$_4$–PC. Voltammograms in a)–c) were recorded for the indicated number of cycles at 50 mV/s; arrows denote sweep direction. Corresponding spectral optical transmittance data in panels a’)–c’) were taken for films in as-deposited state and at full coloration and bleaching after the first and second voltage scan.
Figure 4. a) and b) show cyclic voltammograms for a NiO$_{1.16}$ film immersed in LiClO$_4$–PC. Data were recorded for the indicated number of cycles at 50 mV/s; arrows denote sweep direction. The first cycle starts from the OCP and progresses towards a) low and b) high voltage, respectively. c) and d) report charge density obtained from CV data in a) and b); insets in c) and d) indicate optical transmittance at 550 nm.
Figure 5. Cyclic voltammograms and spectral transmittance taken at the second voltammetric cycle for Ni oxide films with the shown compositions immersed in LiClO₄–PC. Voltammograms, shown in panels a)–c), were recorded for cycling to the indicated values of the upper potential limit at 50 mV/s; arrows denote sweep direction. Corresponding transmittance data, shown in panels a’)–c’), were taken for films in as-deposited state and at full coloration and bleaching.
Figure 6. Exchanged charge density during bleaching and coloring vs. voltammetric cycle number for Ni oxide films with the shown compositions immersed in LiClO$_4$–PC and cycled at 50 mV/s in the shown potential windows. Note that the vertical scales are different among the various panels.
Figure 7. Determination of fractal dimension $d_f$ for Ni oxide film surfaces. a) CV curves for a NiO$_{1.16}$ film at the shown voltage sweep rates; the current at the arrow (denoted I) was used to evaluate $d_f$. b) Peak current, extracted from voltammograms such as the one in a), vs. potential scan rate for NiO$_x$ films with the shown values of $x$. The parameter $\alpha$ was obtained from a power-law fit to the data points, which then yielded $d_f$. 
Figure 8. a) (100) plane of $fcc$ NiO; oxygen and nickel atoms are in the same plane and exposed equally to air. b) (111) plane of $fcc$ NiO; oxygen and atoms and nickel atoms are not in the same plane, and nickel atoms are predominantly exposed to air.